

<b>Notice of References Cited</b>	Application/Control No. 10/633,705	Applicant(s)/Patent Under Reexamination TSURU ET AL.	
	Examiner Callie E. Shosho	Art Unit 1714	Page 1 of 1

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	N	EP 1113051 A1	07-2001	<u>                    </u>	HIDAKA et al.	<u>                    </u>
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